Characterising SiPMs for the Analogue Hadronic Calorimeter for the ILC

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10 years KIRCHHOFF-INSTITUTE FOR PHYSICS

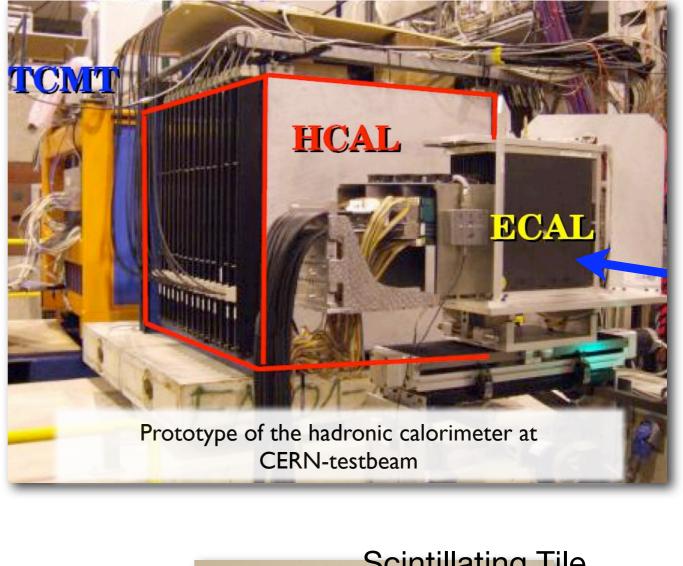


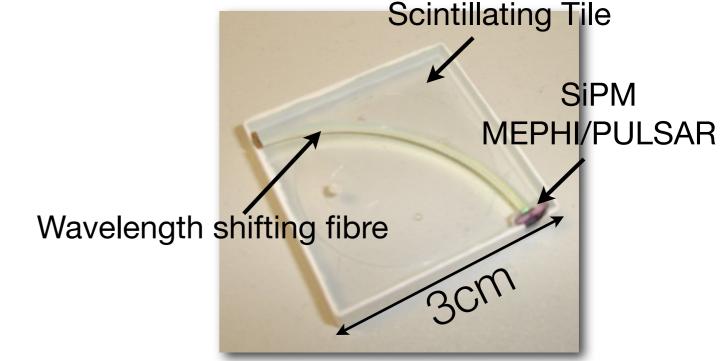
Outline

- Analogue Hadronic Calorimeter (AHCAL) for the ILC
- Silicon Photomultiplier (SiPM) Introduction
- Essential SiPM Characterisation
 - Photon Detection Efficiency
- SiPM Readout Chip
- Tile Coupling Studies
- Development of Embedded LED Calibration System

Highly Granular Hadronic Calorimeter

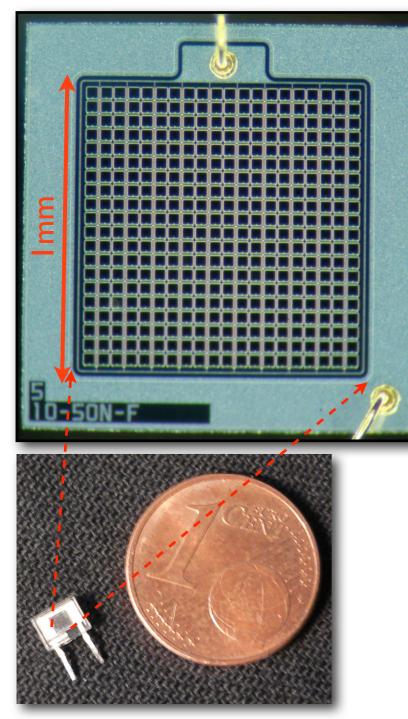
- Sandwich Calorimeter 38 Layers
 Steel / Plastic Scintillator Tiles
- \approx 7600 Tiles with SiPM readout
- Several SiPM producers and sensor types on the market
- Future: Different Tile geometrics and readout schemes possible
- Which ones are suitable?
 - Characterisation studies necessary

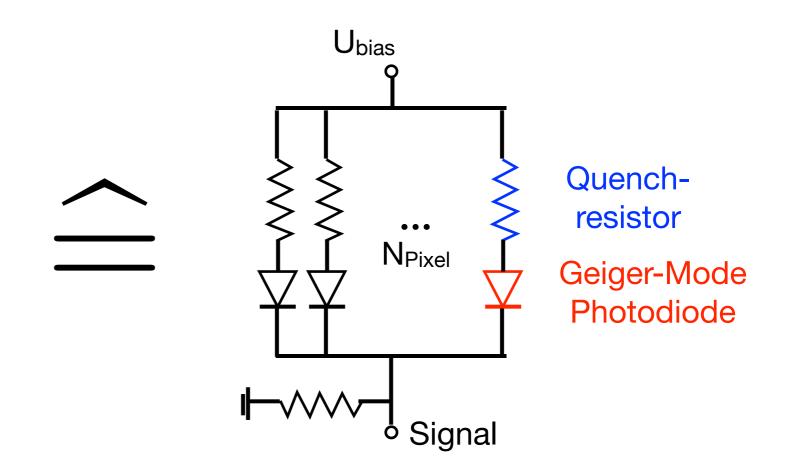




Silicon Photomultiplier (SiPM)

Geiger-Mode Avalanche-Photodiode GAPD, Pixelised Photon Detector PPD, Multi Pixel Photon Conter MPPC (HAMAMATSU)

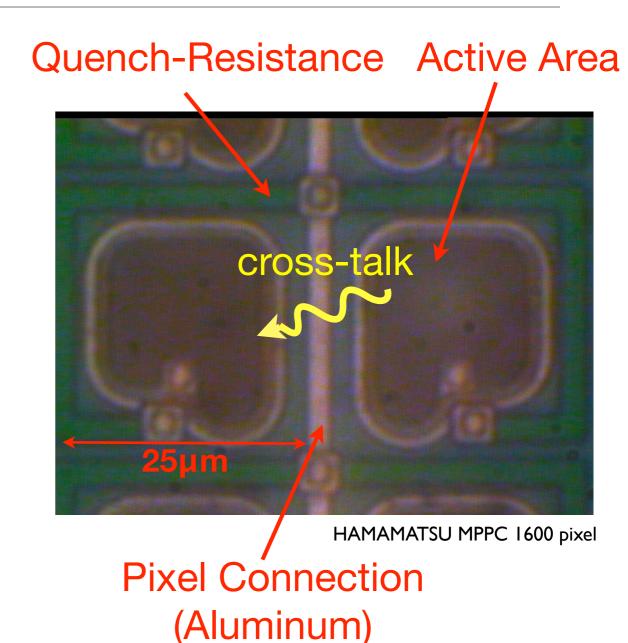




- Geiger Mode (U_{bias} > U_{break}) → Binary device!
- Pixels signals are summed up --> Linear response if N_{photon} << N_{pixel}

SiPM Properties

- High Gain O(10⁶)
- Low operating voltage (<100V)
- Compact (few mm)
- Magnetic field insensitive
- But there are also drawbacks:
- Optical cross-talk (CT) 3x10⁻⁵ photons per charge carrier traversing the junction G=10⁶ → 30 photons (E>1.14eV)
- After-pulses (AP) Delayed Avalanche caused by trapped electrons



PDE Measurement

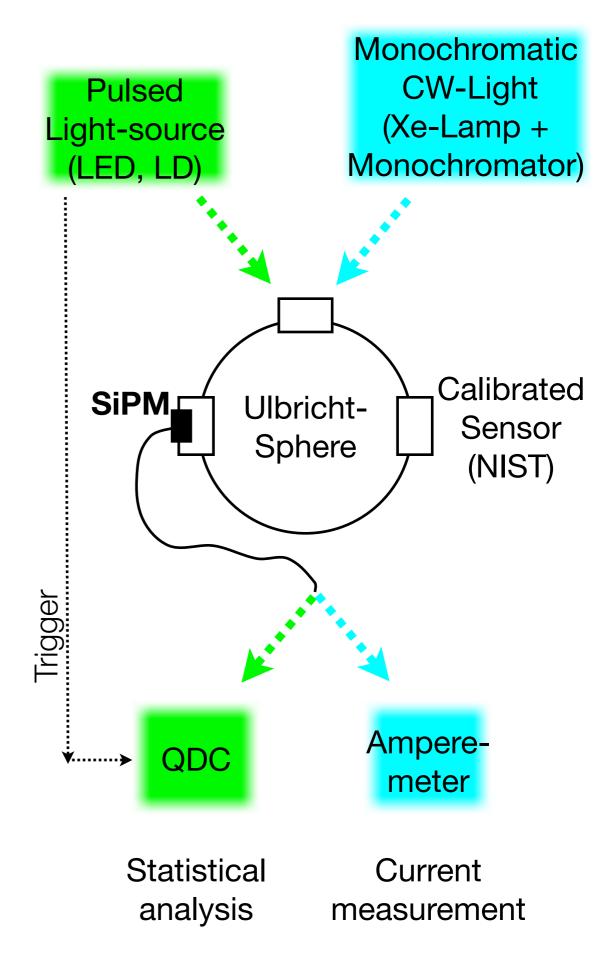
(KIP Heidelberg)

- Problem: Cross-talk and after-pulses cannot be separated from the photon induced signal
- Statistical analysis method allows to measure absolute PDE without CT and AP, but only for individual λ (i.e 465, 635, 775, 870nm)

Current measurement

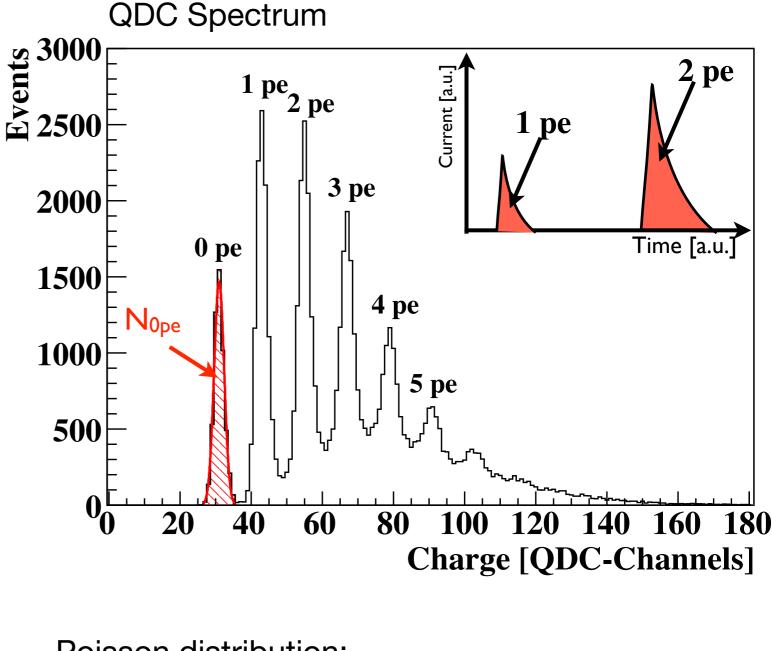
allows to measure **relative PDE** over wide spectral range **(350-1000nm)**, but contains CT and AP

• Idea: Scaling of relative PDE



Absolute PDE (Statistical Analysis)

- QDC readout is triggered independent from SiPM signal
- By measuring the number of times no photon was detected
 N_{0pe}, the average number of detected photons n_{pe} can be calculated (poisson dist.)
- Since N_{0pe} is not influenced by CT and AP (no pixel is firing), n_{pe} can be used to calculate the absolute PDE

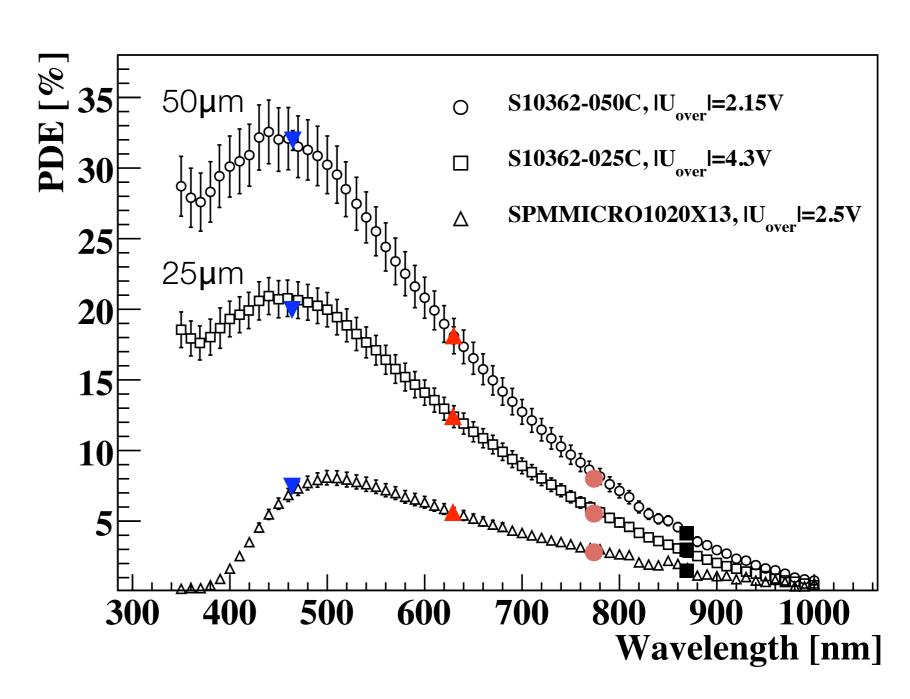


Poisson distribution:

$$P(n, n_{pe}) = \frac{n_{pe}^{n} \cdot e^{-n_{pe}}}{n!} \Rightarrow P(0, n_{pe}) = e^{-n_{pe}}$$
$$\Rightarrow n_{pe} = -\ln\left(\frac{N_{0pe}}{N_{Tot.}}\right)$$

PDE: Wavelength dependent

- Relative PDE curves have been scaled to the highest absolute PDE at 633nm.
- PDE values at 465, 775 and 870nm are in good agreement
 - Consistency check
- MPPC: high PDE in blue region
- SensL SPM: more green sensitive

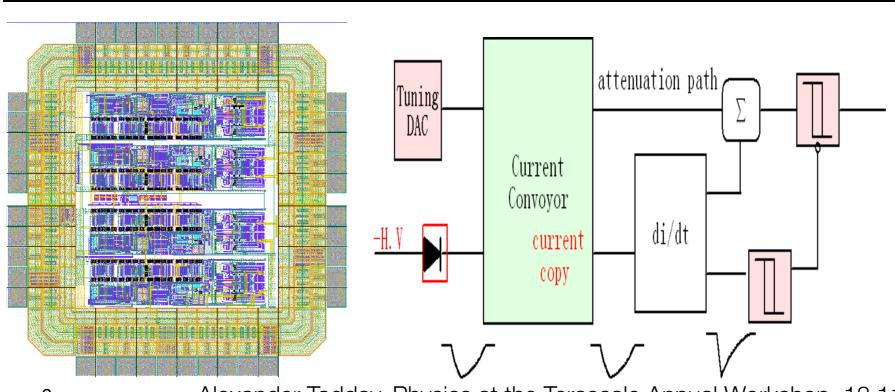


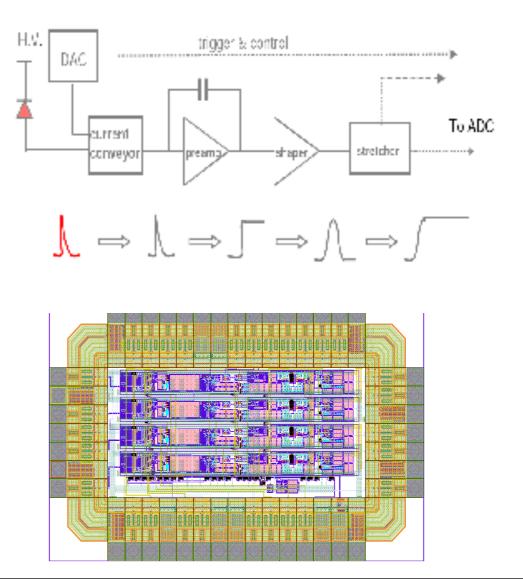
SiPM Readout Chip

(KIP Heidelberg)

SiPM charge sensitive readout

- tunable Sensor bias
- high signal to noise ratio
 (>10 for SiPM gain = 2.5x10⁵)
- fast trigger available for discrimination
- test chip with 4 channels
- Submitted in Oct. 2009
- AMS 0.35 um CMOS





Fast Timing readout Chip

LVDS output Leading edge & CF triggering Time walk for 10:1 signal 80ps Time jitter ~ 15ps Power < 10 mW / channel 4 channels Submitted in Oct. 2009 AMS 0.35um CMOS

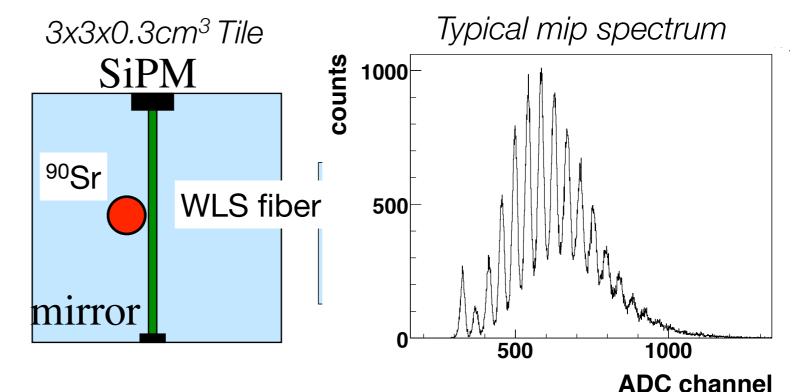
Tile Coupling Study (DESY Hamburg)

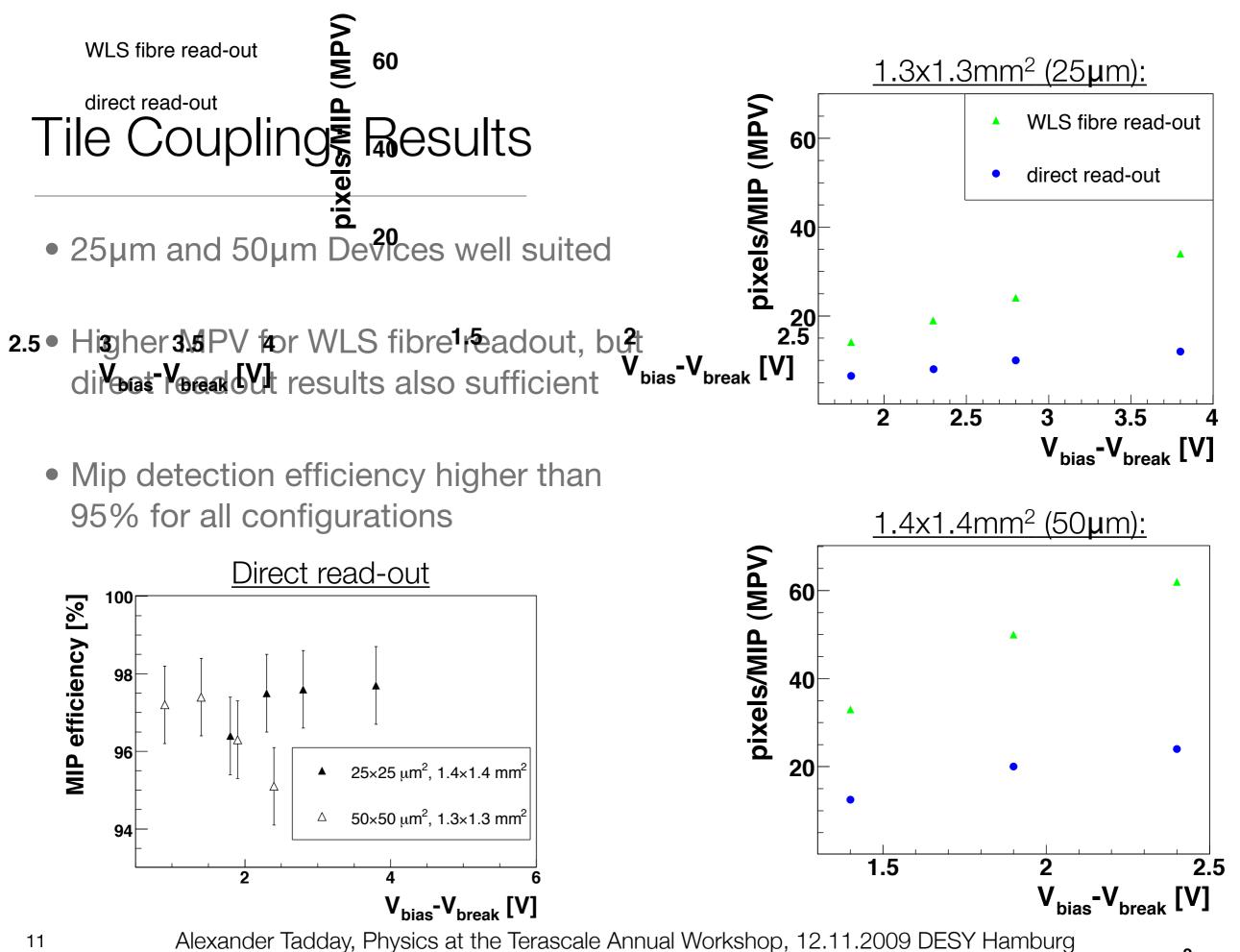
- Wavelength shifting fiber vs. direct coupling (simpler assembly, cheaper)
- Source for Minimum ionizing particles (mips): ⁹⁰Sr
- Second tile with PMT readout used for trigger
- mip spectra recorded for different Tile-SiPM configurations
 Most probable value (MPV)

# Pixels	Bias	Dark Rate	Pixel Size	Gain	PDE
(size [mm ²])	[V]	(0.5 p.e. threshold)	$[\mu m^2]$	(10^5)	[%]
1600 (1x1)	70.4	200	25x25	2.5	25
3136 (1.4x1.4)	71.8	550 (200 kHz/mm ²)	25x25	2.5	25
400 (1x1)	69.4	600	50x50	7.5	50
676 (1.3x1.3)	70.5	900 (530 kHz/mm ²)	50x50	7.5	50
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MPPCs used in study

Contains CT and AP



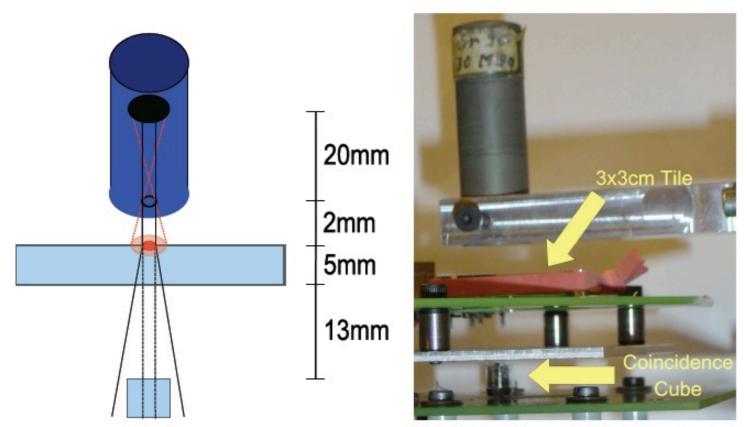


Fiberless Readout of Scintillator Tiles

(MPI for Physics & Excellence Cluster 'Universe', Munich)

Blue sensitive SiPMs do not require a WLS fiber for readout

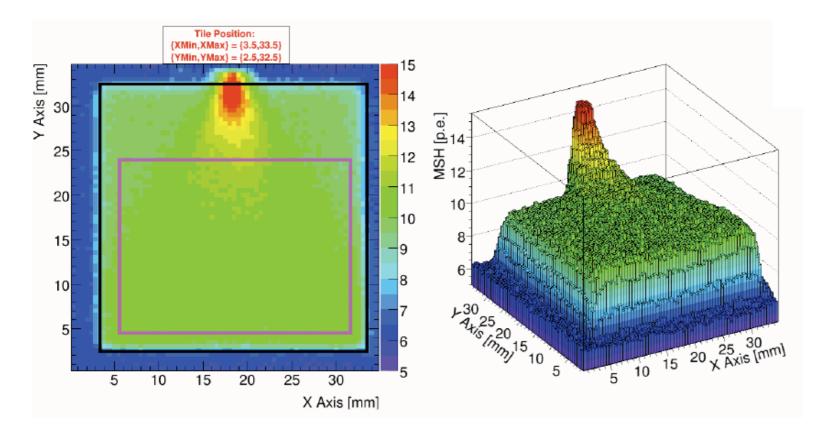
- Advantages:
 - Simplified mechanics, alignment of SiPM
 - Faster response: No spreading of pulse due to WLS absorption and reemission
- Drawback:
 - WLS fiber collects light and guides it to the SiPM: improves uniformity!
 - Optimize tile geometry to improve uniformity



A scanning setup with a ⁹⁰Sr source and a coincidence trigger for detailed mapping of the response of scintillator tiles has been constructed at MPI Munich

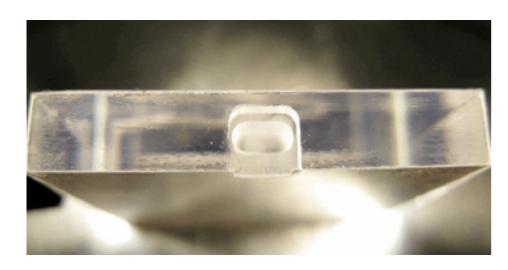
About 50 different tile geometries have been investigated

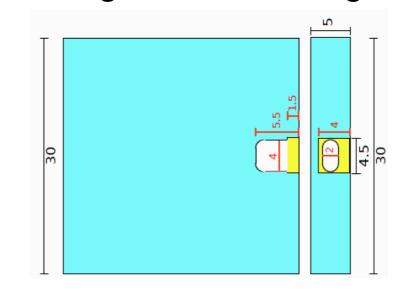
Direct Coupling: Non-Uniformity



Strong non-uniformity, significantly increased response close to SiPM coupling position

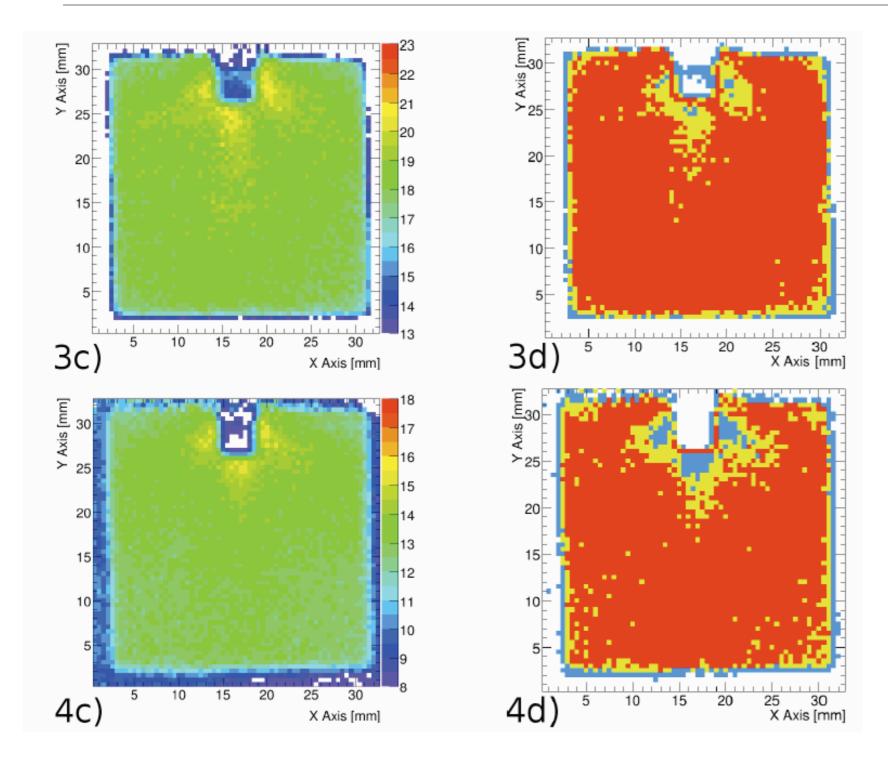
The strategy: reduce material close to coupling position, improve light collection through embedding of SiPM and light diffusion





Add a "dimple" at the SiPM coupling position: Drilled into the tile

Improved Uniformity



4 x 2 mm² slit, 4 mm deep, SiPM embedded (1.5 mm deep) mean signal 18.4 pe

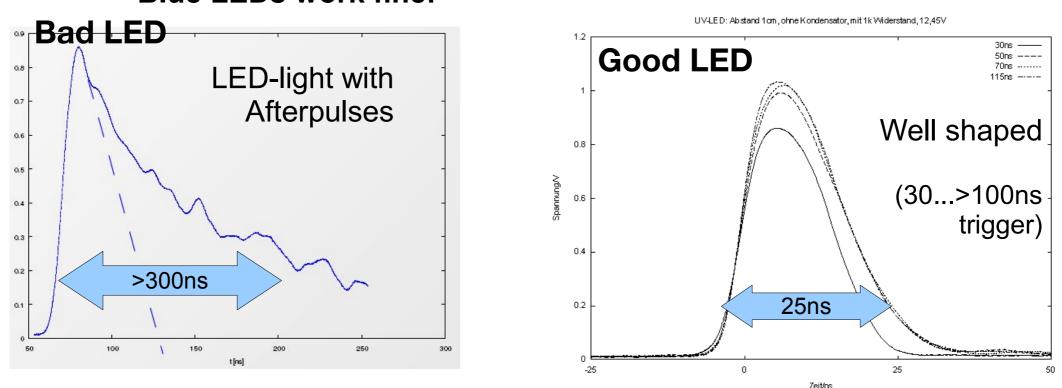
> Typically 5%: ~72% 10%: ~84%

3 mm thick tile! 4 x 2 mm² slit, 4 mm deep, SiPM embedded (1.5 mm deep) mean signal 13.2 pe

Embedded LED calibration system

(Uni Wuppertal)

- One LED plus driver placed over each AHCAL tile, triggered by dedicated signal
- Driving circuit has been optimized to match needs of single photon spectra
 - Sharp, well shaped light pulse
 - Independence of trigger signal length
- Several LEDs of different type, color and manufacturer tested
- Most suitable, some show undesirable behaviour (afterpulsing)



Blue LEDs work fine!

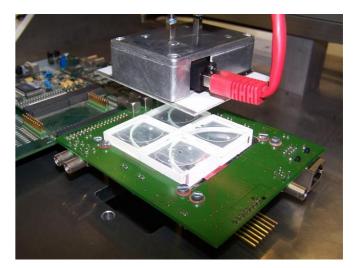
LED Position

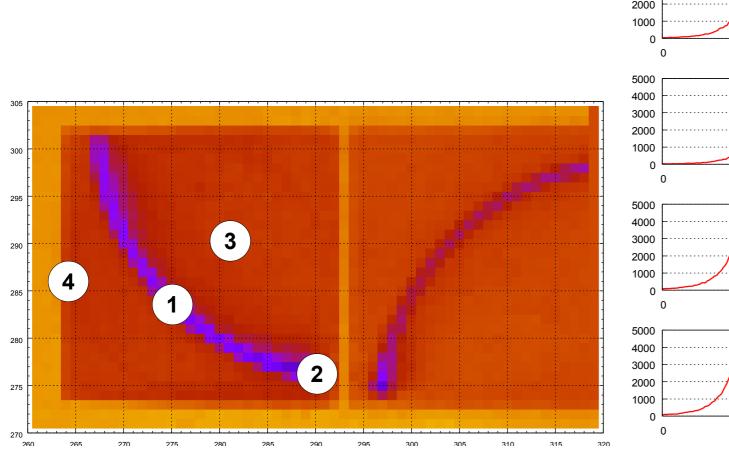
- XY stage to place LED on HCAL tiles
- Quickly exchangable LED&Driver PCB
- Surface scan shows structure of tiles

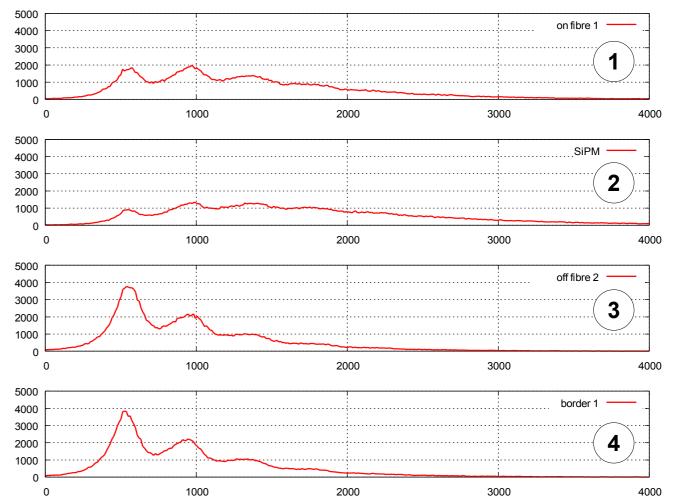
In the future: scans with Sr90

ullet

 Fiber shows gain of ~2 in SiPM-signal, but also more noise (LED over SiPM: ~3)







Conclusion

- Test stand for essential SiPM characterisation
 PDE, Cross-talk, After-pulse probabilities ...
- SiPM readout chip submitted in october
- Detailed tile coupling studies covering SiPM selection and tile geometry have been performed
- First results on embedded LED calibration system

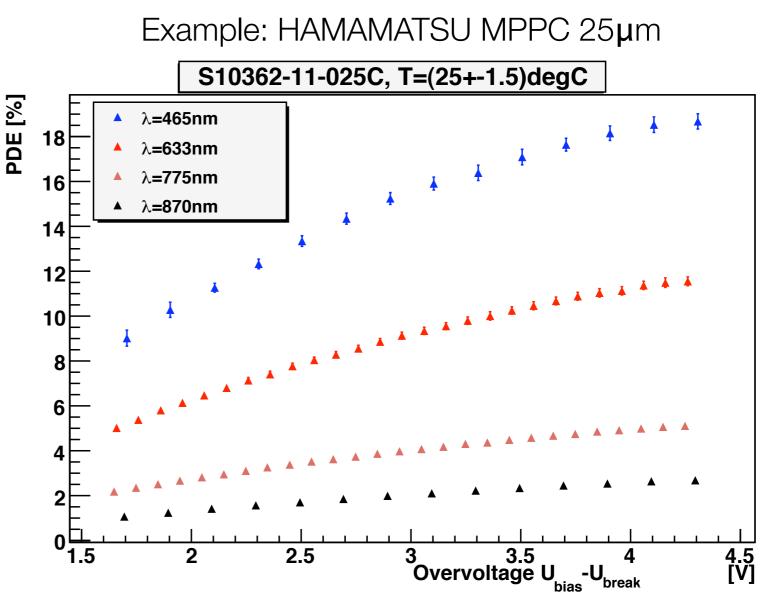
Backup Slides

PDE: Voltage Dependent

- QDC spectra recorded and evaluated for a range of bias voltages
- Highest PDE value at 635nm is used in the next step scaling.

 $\begin{aligned} \text{PDE} &= \frac{N_{\text{SiPM}}}{N_{\text{Photon}}} \\ &= \frac{n_{\text{pe}}}{P_{\text{opt}} \cdot T / (R_{0.6} \cdot h \cdot \frac{c}{\lambda})} \end{aligned}$

- n_{pe}: Photoelectrons per light-pulse
 - T: Light-pulse period
- R_{0.6}: Power-ratio of sphere (Port1/Port2)
- Popt: Optical power measured by calibrated sensor Alexander Tadday, Physics at the Terascale Annual Workshop, 12.11.2009 DESY Hamburg



Temperature dependency

- XY-stage placed in temperature controlled environment
- Studies of temperature dependencies over wide range possible

